## CLAIMS

1. A hydroxypolyamide having a structure represented by the general formula (1):

wherein m and n are integers satisfying m > 0, n  $\geq$  0, 2  $\leq$  m+n  $\leq$  1,000, and 0.05  $\leq$  m/(m+n)  $\leq$  1, and the recurring units may be arranged blockwise or randomly; X represents at least one tetravalent organic group selected from groups represented by the following formula (2); Y represents 5-aminoisophthalic acid having at least one hydrogen atom of the amino group substituted, from which a carboxylic acid group is excluded; and Z represents at least one divalent group selected from groups represented by the following formula (4),

wherein  $X_1$  represents a divalent organic group selected

from groups represented by the following formula (5); and the hydrogen atoms on each aromatic ring may be substituted with at least one group selected from the group consisting of a methyl group, an ethyl group, a propyl group, an isopropyl group, a butyl group, an isobutyl group, a t-butyl group, a fluorine atom, and a trifluoromethyl group,

$$R_{\theta}OOC$$
 $COOR_{\theta}$ 
 $COOR_{\theta}$ 
 $COOR_{\theta}$ 
 $COOR_{\theta}$ 
 $COOR_{\theta}$ 
 $COOR_{\theta}$ 
 $COOR_{\theta}$ 
 $COOR_{\theta}$ 
 $COOR_{\theta}$ 

wherein  $R_8$  represents a monovalent organic group;  $X_1$  represents a divalent organic group selected from groups represented by the following formula (5); and the hydrogen atoms on each aromatic ring may be substituted with at least one group selected from the group consisting of a methyl group, an ethyl group, a propyl group, an isopropyl group, a butyl group, an isobutyl group, a t-butyl group, a fluorine atom, and a trifluoromethyl group, and

wherein the hydrogen atoms on each aromatic ring may be substituted with at least one group selected from the group consisting of a methyl group, an ethyl group, a propyl group, an isopropyl group, a butyl group, an isobutyl group, a t-butyl group, a fluorine atom, and a trifluoromethyl group.

2. The hydroxypolyamide according to claim 1 wherein Y represents at least one divalent organic group selected from groups represented by the following formula (3):

wherein  $R_1$ ,  $R_2$ ,  $R_3$ ,  $R_4$ , and  $R_6$  are each independently a monovalent organic group;  $R_5$  is a divalent organic group;  $R_7$  is at least one group selected from the group consisting of an aralkyl group, an arylsulfenyl group,

- a diarylphosphinyl group, and a tri-substituted silyl group; and the hydrogen atoms on each aromatic ring may be substituted with at least one group selected from the group consisting of a methyl group, an ethyl group, a propyl group, an isopropyl group, a butyl group, an isobutyl group, a t-butyl group, a fluorine atom, and a trifluoromethyl group.
- A resin composition comprising 100 parts by mass of the hydroxypolyamide according to claim 1 or 2 (A) and 70 to 900 parts by mass of an organic solvent (D).
- A resin composition comprising 100 parts by mass of the hydroxypolyamide according to claim 1 or 2 (A), 1 to 50 parts by mass of a crosslinking agent (B), and 70 to 900 parts by mass of an organic solvent (D).
- A resin composition comprising 100 parts by mass of the hydroxypolyamide according to claim 1 or 2 (A), 1 to 100 parts by mass of an optically active compound with a naphtoquinonediazide group (C), and 70 to 900 parts by mass of an organic solvent (D), and having positive photosensitivity.
- A resin composition comprising 100 parts by mass of the hydroxypolyamide according to claim 1 or 2 (A), 1 to 50 parts by mass of a crosslinking agent (B), 1 to 100 parts by mass of an optically active compound with a naphtoquinonediazide group (C), and 70 to 900 parts by mass of an organic solvent (D), and having positive photosensitivity.

- 7. The resin composition according to claim 4 or 6 wherein the crosslinking agent (B) is an acrylate compound.
- 8. The resin composition according to claim 4 or 6 wherein the crosslinking agent (B) is an epoxy compound.
- 9. A process for producing a cured relief pattern, comprising the steps of: applying the resin composition according to claim 5 or 6 onto a substrate; exposing the resultant coating film to an active light through a mask or directly irradiating the coating film with actinic rays; eluting and removing the part exposed or irradiated with the actinic rays using a developer; and heating the resultant positive relief pattern at 150 to 400°C.
- 10. A semiconductor device having a layer made of a cured relief pattern obtained by the production process according to claim 9.